Power LDMOS transistor

Rev. 3 — 14 October 2011

Product data sheet

1. Product profile

1.1 General description

250 W LDMOS power transistor intended for CW applications at a frequency of 1.3 GHz.

Table 1. Test information

Typical RF performance at $T_{case} = 25 \ ^{\circ}C$; $I_{Dq} = 100 \ mA$; in a class-AB production test circuit.

Mode of operation	f	V _{DS}	P _{L(1dB)}	Gp	η _D
	(GHz)	(V)	(W)	(dB)	(%)
CW	1.3	50	250	17	56

1.2 Features and benefits

- Typical CW performance at a frequency of 1.3 GHz, a supply voltage of 50 V, an I_{Dq} of 100 mA:
 - Output power = 250 W
 - Power gain = 17 dB
 - Efficiency = 56 %
- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

Industrial, scientific and medical applications



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2. Pinning information

Pin	Description	Simplified outline	Graphic symbol
BLF6G1	3L-250P (SOT1121A)		
1	drain1		
2	drain2	1 2 []	
3	gate1		
4	gate2		3 5
5	source		
			2
BI E6C1	3LS-250P (SOT1121B)		sym117
1	drain1		
		1 2	1
	drain2	רא רא	
2	drain2 gate1		
2 3 4	gate1		
2 3 4	gate1 gate2		
2 3	gate1	5	

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information					
Type number	Packag	le			
	Name	Description	Version		
BLF6G13L-250P	-	flanged LDMOST ceramic package; 2 mounting holes; 4 leads	SOT1121A		
BLF6G13LS-250P	-	earless flanged LDMOST ceramic package; 4 leads	SOT1121B		

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage		-	100	V
V _{GS}	gate-source voltage		-0.5	+13	V
I _D	drain current		-	42	А
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

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5. Thermal characteristics

Table 5.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-c)}	thermal resistance from junction to case	T_{case} = 85 °C; P_L = 250 W	0.26	K/W

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C; per section unless otherwise specified.

,	/1 I					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 1.4 mA	100	-	-	V
V _{GS(th)}	gate-source threshold voltage	V_{DS} = 10 V; I_{D} = 235 mA	1.4	1.8	2.4	V
I _{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 50 V	-	-	1.4	μA
I _{DSX}	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{\text{GS}} = V_{\text{GS(th)}} + 3.75 \ \text{V}; \\ V_{\text{DS}} = 10 \ \text{V} \end{array}$	-	21	-	A
I _{GSS}	gate leakage current	V_{GS} = 11 V; V_{DS} = 0 V	-	-	240	nA
9 _{fs}	forward transconductance	V_{DS} = 10 V; I_{D} = 120 mA	-	1	-	S
R _{DS(on)}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{\text{GS}} = V_{\text{GS}(\text{th})} + 3.75 \; V; \\ I_{\text{D}} = 4.75 \; A \end{array}$	-	200	-	mΩ

Table 7. RF characteristics

Mode of operation: CW; f = 1.3 GHz; RF performance at $V_{DS} = 50 \text{ V}$; $I_{Dq} = 100 \text{ mA}$; $T_{case} = 25 \text{ °C}$; unless otherwise specified, in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PL	output power		250	-	-	W
V _{DS}	drain-source voltage	$P_{L} = 250 \text{ W}$	-	-	50	V
G _p	power gain	$P_{L} = 250 \text{ W}$	15	17	-	dB
RL _{in}	input return loss	$P_{L} = 250 \text{ W}$	-	-30	-20	dB
η_D	drain efficiency	$P_{L} = 250 \text{ W}$	52	56	-	%

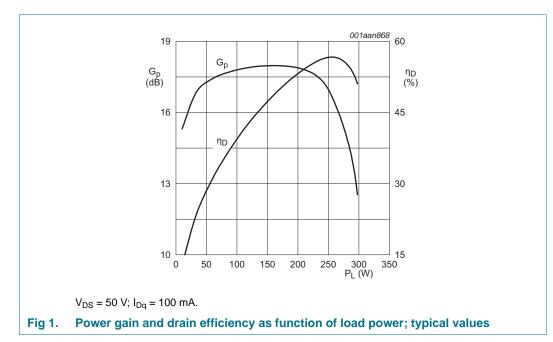
6.1 Ruggedness in class-AB operation

The BLF6G13L-250P and BLF6G13LS-250P are capable of withstanding a load mismatch corresponding to VSWR = 5 : 1 through all phases under the following conditions: $V_{DS} = 50$ V; $I_{Dq} = 100$ mA; $P_L = 250$ W; f = 1.3 GHz.

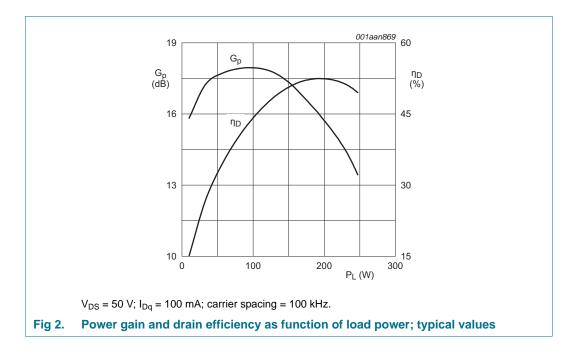
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7. Application information

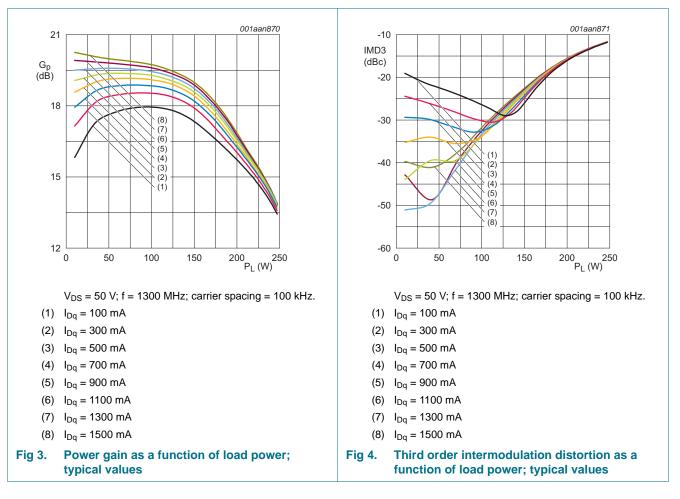
7.1 CW



7.2 2-Carrier CW



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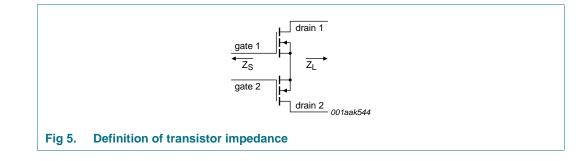


7.3 Impedance information

Table 8. Typical impedance

Typical values valid per section unless otherwise specified.

	1	I	
f	Zs	Z_L optimized for G_p	Z_L optimized for η_D
MHz	Ω	Ω	Ω
1200	3.03 – j8.15	2.03 - j0.25	1.46 – j0.47
1300	4.06 – j9.52	1.67 – j0.92	1.19 – j0.95
1400	7.00 – j9.61	1.50 – j1.48	1.22 – j1.49



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7.4 Circuit information

Table 9.List of components

For application circuit see Figure	<u>6</u> .
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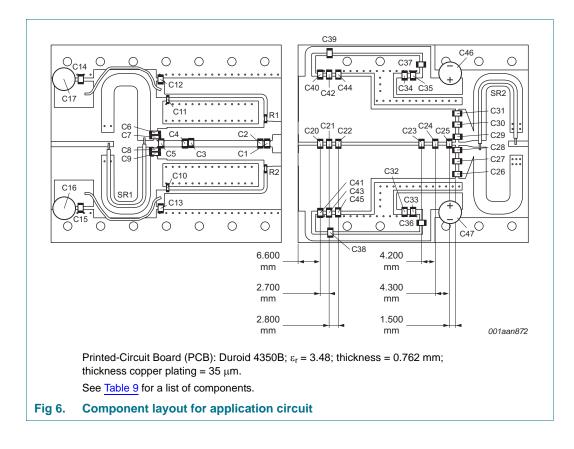
Component	Description	Value	Remarks
C1, C2	multilayer ceramic chip capacitor	1.9 pF	<u>[1]</u>
C3, C4	multilayer ceramic chip capacitor	4.7 pF	<u>[1]</u>
C5	multilayer ceramic chip capacitor	10 pF	<u>[1]</u>
C6, C7, C8, C9, C10, C11, C38, C39	multilayer ceramic chip capacitor	56 pF	<u>[1]</u>
C12, C13	multilayer ceramic chip capacitor	100 pF	[2]
C14, C15, C32, C34	multilayer ceramic chip capacitor	1 nF	[2]
C16, C17	electrolytic capacitor	10 μF; 50 V	220 X5R
C20, C21, C22, C23	multilayer ceramic chip capacitor	3.0 pF	<u>[1]</u>
C40, C41	multilayer ceramic chip capacitor	2.4 pF	<u>[1]</u>
C42, C43, C44, C45	multilayer ceramic chip capacitor	2.7 pF	<u>[1]</u>
C24	multilayer ceramic chip capacitor	0.8 pF	<u>[1]</u>
C25	multilayer ceramic chip capacitor	0.6 pF	<u>[1]</u>
C26, C27, c28, C29, C30, C31, C33, C35	multilayer ceramic chip capacitor	100 pF	[1]
C36, C37	multilayer ceramic chip capacitor	20 nF	[3]
C46, C47	electrolytic capacitor	100 μF; 63 V	
R1, R2	SMD resistor 0603	5.1 Ω	UT-141C-25-TP
SR1	COAX	25 Ω	UT-141C-35-TP
SR2	COAX	35 Ω	

[1] American Technical Ceramics type 800B or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

[3] American Technical Ceramics type 200B or capacitor of same quality.

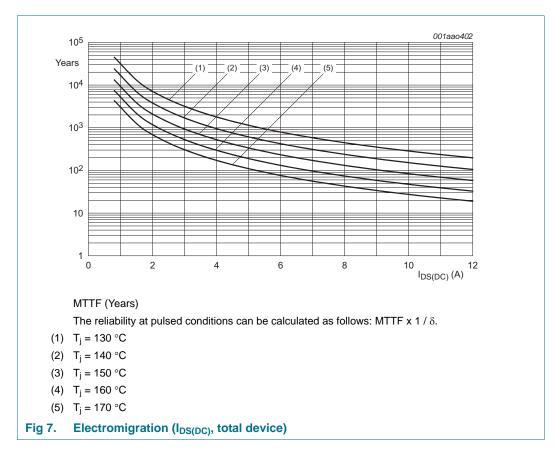
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8. Test information

8.1 Reliability



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9. Package outline

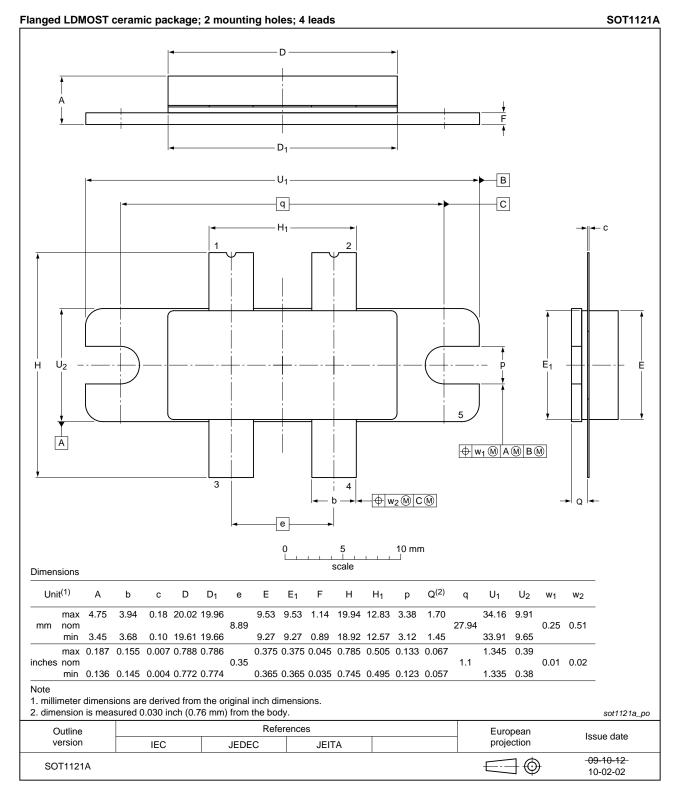


Fig 8. Package outline SOT1121A

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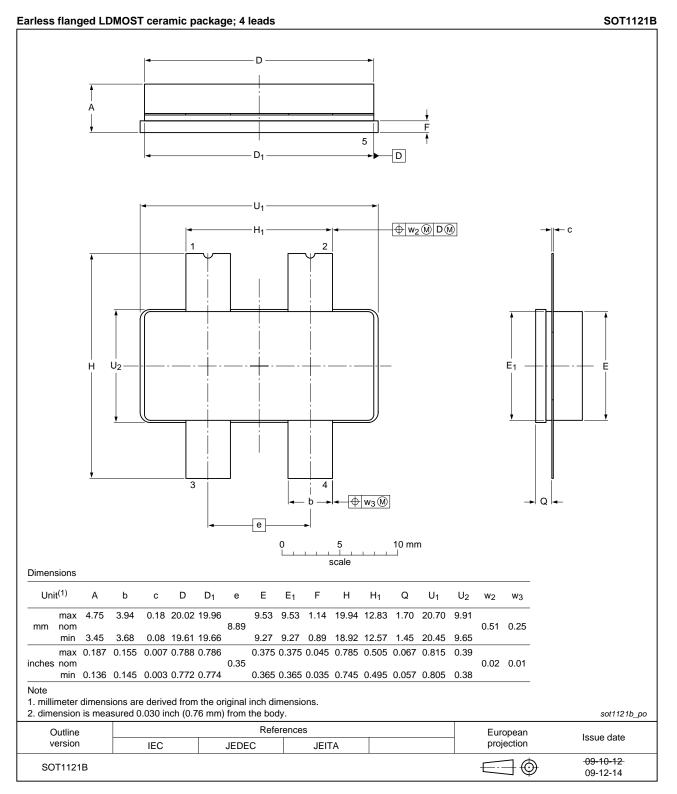


Fig 9. Package outline SOT1121B

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10. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

11. Abbreviations

Table 10.	Abbreviations
Acronym	Description
CW	Continuous Wave
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
MTTF	Mean Time To Failure
RF	Radio Frequency
SMD	Surface Mount Device
VSWR	Voltage Standing-Wave Ratio

12. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BLF6G13L-250P_6G13LS-250P v.3	20111014	Product data sheet	-	BLF6G13L-250P_ 6G13LS-250P v.2	
Modifications:	 <u>Table 6 on page 3</u>: Several values have been updated 				
	 <u>Table 7 on page 3</u>: The minimum value for η_D has been updated 				
	 Section 8.1 	1 on page 8: This section	n has been added		
BLF6G13L-250P_6G13LS-250P v.2	20110321	Objective data sheet	-	BLF6G13L-250P_	
				6G13LS-250P v.1	
BLF6G13L-250P_6G13LS-250P v.1	20101102	Objective data sheet	-	-	

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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